

Application/Control No.	Applicant(s)/Patent under Reexamination		
09/887,854	BANKIEWICZ ET AL.		
Examiner	Art Unit		
Shin-Lin Chen	1632		

SEARCHED					
Class	Subclass	Date	Examiner		
424	93.2, 93.21, 93.6				
435	320.1				
435	455	·			
514	44	3/10/2005	EN		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
424	93.6			
424	93.2			
424	93.21			
	5//320.1, 455, ence search	3/10/2005	gu	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
WEST, STN, Medline, Caplus, Biosis, Scisearch, parent reviewed and updated. Inventor name search.	3/10/2005	gu
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